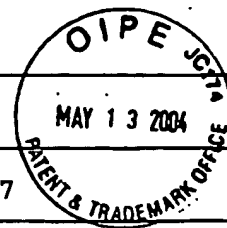


FORM PTO 1449 (modified)

U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY APPLICANT(S)  
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Date Submitted to PTO: May 13, 2004

ATTY DOCKET N  
2003-0902ASERIAL NO.  
10/609,477APPLICANT  
Satoshi ENDO et al.FILING DATE  
July 1, 2003GROUP  
~~2015~~ 2627

## U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
TD	AJ	11-250567	09/1999	JP	—	—	partial + abstract
↓	AK	2000-357367	12/2000	JP	—	—	partial + abstract
↓	AL	2001-312865	11/2001	JP	—	—	partial + abstract
TD	AM	2002-170239	06/2002	JP	—	—	partial + abstract
	AN						

## OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

	AO	
	AP	
	AQ	

EXAMINER /Tan Dinh/

DATE CONSIDERED 08/09/2006

Sheet 1 of 1		FORM PTO 1449 (modified)		ATTY DOCKET NO. 2003_0902A		SERIAL NO. 10/609,477	
U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE				APPLICANT Satoshi ENDO et al.			
LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)							
Date Submitted to PTO: December 15, 2003				FILING DATE July 1, 2003		GROUP <del>2645</del> 2627	

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
TD	AA	6,388,959	5/2002	Kondo	—	—	
TD	AB	5,926,449	7/1999	Hiok et al.	—	—	
TD	AC	5,612,933	3/1997	Iso et al.	—	—	
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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO	
TD	AJ	1 130 588	9/2001	EP	—	—		
TD	AK	7-37341	2/1995	JP	—	—	Abstract	
	AL							
	AM							
	AN							

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

	AO	
	AP	
	AQ	

EXAMINER /Tan Dinh/	DATE CONSIDERED 08/09/2006
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\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include cop. this form with next communication to applicant.